

UNISONIC TECHNOLOGIES CO., LTD

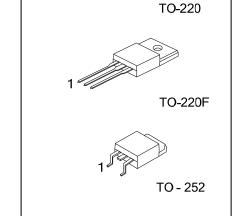
6N50 **Preliminary Power MOSFET**

N-CHANNEL 6A, 500V **POWER MOSFET**

DESCRIPTION

The UTC 6N50 is a N-channel mode power MOSFET using UTC's advanced technology to provide customers with planar stripe and DMOS technology. This technology allows a minimum on-state resistance and superior switching performance. It also can withstand high energy pulse in the avalanche and commutation mode.

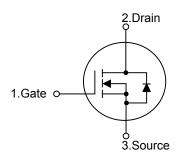
The UTC 6N50 is generally applied in high efficiency switch mode power supplies, active power factor correction and electronic lamp ballasts based on half bridge topology.



FEATURES

- * $R_{DS(ON)}$ < 1.15 Ω @ V_{GS} =10V, I_{D} =3.0A
- * High Switching Speed
- * 100% Avalanche Tested

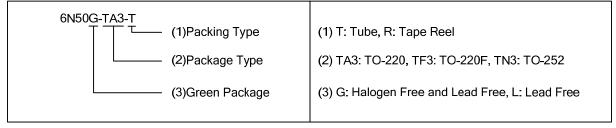
SYMBOL



ORDERING INFORMATION

Ordering Number		Dookogo	Pin	Dooking			
Lead Free	Halogen Free	Package	1	2	3	Packing	
6N50L-TA3-T	6N50G-TA3-T	TO-220	G	D	S	Tube	
6N50L-TF3-T	6N50G-TF3-T	TO-220F	G	D	S	Tube	
6N50L-TN3-R	6N50G-TN3-R	TO-252	G	D	S	Tape Reel	

Note: Pin Assignment: G: Gate D: Drain S: Source



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■ **ABSOLUTE MAXIMUM RATINGS** (T_C=25°C, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT
Drain-Source Voltage		V_{DSS}	500	V
Gate-Source Voltage		V_{GSS}	±30	V
Drain Current	Continuous (T _C =25°0	C) I _D	6 (Note 2)	Α
	Pulsed (Note 3)	I _{DM}	24 (Note 2)	А
Avalanche Current (Note 3)		I _{AR}	6	А
Avalanche Energy	Single Pulsed (Note	4) E _{AS}	270	mJ
	Repetitive (Note 5)	E _{AR}	20	mJ
Peak Diode Recovery dv/dt (Note 5)		dv/dt	4.5	V/ns
Power Dissipation (T _C =25°C) TO-220 TO-220F TO-252)	89	W
		F P _D	31	W
		2	56	W
Junction Temperature		TJ	+150	°C
Storage Temperature		T _{STG}	-55 ~ +150	°C

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged.

Absolute maximum ratings are stress ratings only and functional device operation is not implied.

- 2. Drain current limited by maximum junction temperature.
- 3. Repetitive Rating: Pulse width limited by maximum junction temperature.
- 4. L =13mH, I_{AS} = 6.0A, V_{DD} = 50V, R_{G} = 25 Ω , Starting T_{J} = 25 $^{\circ}$ C C
- 5. $I_{SD} \le 6.0$ A, di/dt ≤ 200 A/ μ s, $V_{DD} \le BV_{DSS}$, Starting $T_J = 25$ °C

■ THERMAL DATA

PARAMETER		SYMBOL	RATINGS	UNIT	
	TO-220		62.5	°C/W	
Junction to Ambient	TO-220F	θ_{JA}	62.5	°C/W	
	TO-252		110	°C/W	
	TO-220		1.4	°C/W	
Junction to Case	TO-220F	θ_{JC}	4.0	°C/W	
	TO-252		2.23	°C/W	

■ **ELECTRICAL CHARACTERISTICS** (T_C=25°C, unless otherwise noted)

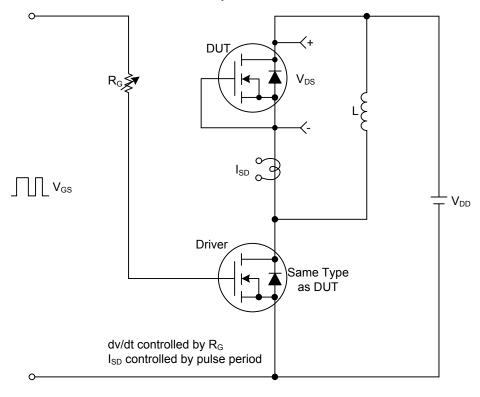
PARAMETER		SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT	
OFF CHARACTERISTICS								
Drain-Source Breakdown Voltage		BV_{DSS}	$I_D=250\mu A, V_{GS}=0V$	500			V	
Drain-Source Leakage Current		I_{DSS}	V _{DS} =500V, V _{GS} =0V			10	μΑ	
Gate- Source Leakage Current	vard	I _{GSS}	V_{GS} =+30V, V_{DS} =0V			+100	nA	
Revenue Leakage Current	erse		V_{GS} =-30V, V_{DS} =0V			-100	nA	
ON CHARACTERISTICS								
Gate Threshold Voltage		$V_{GS(TH)}$	$V_{DS}=V_{GS}$, $I_{D}=250\mu A$	2.0		4.0	V	
Static Drain-Source On-State Resistance		R _{DS(ON)}	V _{GS} =10V, I _D =3.0A		0.95	1.15	Ω	
DYNAMIC PARAMETERS								
Input Capacitance		C_{ISS}			720	960	pF	
Output Capacitance		Coss	V_{GS} =0V, V_{DS} =25V, f=1.0MHz		85	115	pF	
Reverse Transfer Capacitance		C _{RSS}			6.3	10	pF	
SWITCHING PARAMETERS								
Total Gate Charge		Q_G	V _{GS} =10V, V _{DS} =400V, I _D =6.0A		15	20	nC	
Gate to Source Charge		Q_{GS}	(Note 1, 2)		4.5		nC	
Gate to Drain Charge		Q_GD	(14010-1, 2)		6		nC	
Turn-ON Delay Time		$t_{D(ON)}$			17	45	ns	
Rise Time		t_R	V_{DD} =250V, I_{D} =6.0A, R_{G} =25 Ω		30	70	ns	
Turn-OFF Delay Time		$t_{D(OFF)}$	(Note 1, 2)		35	80	ns	
Fall-Time		t _F			20	50	ns	
SOURCE- DRAIN DIODE RATINGS	AND C	HARACTERI	STICS					
Maximum Body-Diode Continuous Current		Is				6	Α	
Maximum Body-Diode Pulsed Current		I _{SM}				24	Α	
Drain-Source Diode Forward Voltage		V_{SD}	I _S =6.0A, V _{GS} =0V			1.5	V	
Body Diode Reverse Recovery Time		t _{rr}	I _S =6.0A, V _{GS} =0V,		85		ns	
Body Diode Reverse Recovery Charge		Q _{rr}	dl _F /dt=100A/μs (Note 1)		0.15		μC	

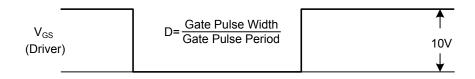
Notes: 1. Pulse Test: Pulse width \leq 300 μ s, Duty cycle \leq 2%.

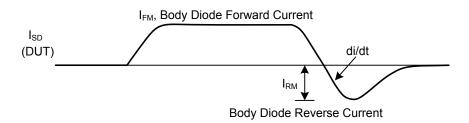
^{2.} Essentially independent of operating temperature.

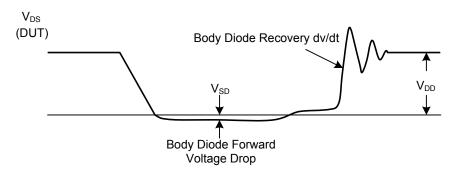
■ TEST CIRCUITS AND WAVEFORMS

Peak Diode Recovery dv/dt Test Circuit & Waveforms



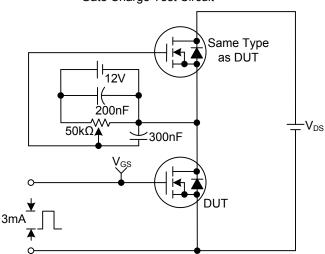




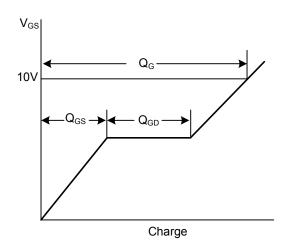


■ TEST CIRCUITS AND WAVEFORMS

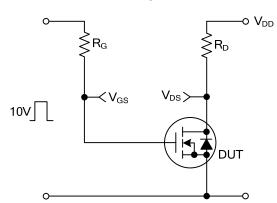
Gate Charge Test Circuit



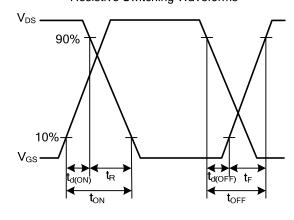
Gate Charge Waveforms



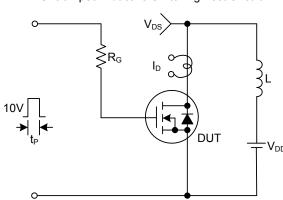
Resistive Switching Test Circuit



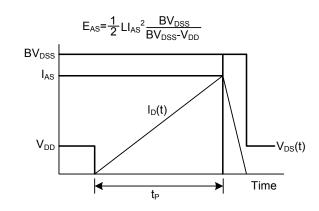
Resistive Switching Waveforms



Unclamped Inductive Switching Test Circuit



Unclamped Inductive Switching Waveforms



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